

Notic of References Cited

Application/Control No. 10/057,779	Reexamination	Applicant(s)/Patent Under Reexamination MATSUDA ET AL.		
Examiner	Art Unit			
Leith A Al-Nazer	2828	Page 1 of 1		

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,111,642	08-2000	DeFreez et al.	356/337
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